

AOT66916L/AOB66916L

100V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGT[™] technology
- Best in class on-resistance R_{DS(ON)}
- Lowers switching loss by lower Qrr than other MOSFET suppliers
- Optimized voltage spike at SSR application
- RoHS and Halogen-Free Compliant

Applications

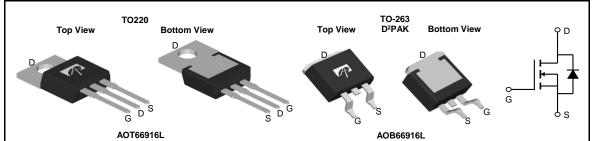
- High frequency switching and synchronous rectification
- BMS
- Motor

Product Summary

 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 120A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 3.6 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 6V) & < 4.8 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOT66916L	TO-220	Tube	1000
AOB66916L	TO-263	Tape & Reel	800

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C	1	120		
Current ^G	T _C =100°C	I _D	120	A	
Pulsed Drain Current ^Ĉ		I _{DM}	450		
Continuous Drain Current	T _A =25°C		35.5	А	
	T _A =70°C	IDSM	28.5	A .	
Avalanche Current ^C		I _{AS}	80	А	
Avalanche energy	L=0.1mH	E _{AS}	320	mJ	
Power Dissipation ^B	T _C =25°C	В	277	W	
	T _C =100°C	P _D	111	VV	
Power Dissipation ^A	T _A =25°C	В	8.3	W	
	T _A =70°C	P _{DSM}	5.3	VV	
Junction and Storag	e Temperature Range	T_J , T_{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	12	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	N _θ JA	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.35	0.45	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		100			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V				1	μA
D00			T _J =55°C			5	r
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.5	2.95	3.5	V
	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =20A	_{GS} =10V, I _D =20A		3.0	3.6	mΩ
R _{DS(ON)}			T _J =125°C		4.9	5.9	11122
		$V_{GS}=6V$, $I_D=20A$			3.6	4.8	mΩ
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$			80		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.68	1	V
Is	Maximum Body-Diode Continuous Curr	ent ^G			120	Α	
DYNAMIC	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz			6180		pF
Coss	Output Capacitance				1660		pF
C _{rss}	Reverse Transfer Capacitance				29		pF
R_g	Gate resistance	f=1MHz		0.7	1.5	2.3	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A			78		nC
Q_{gs}	Gate Source Charge				22		nC
Q_{gd}	Gate Drain Charge				15		nC
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =50V			134		nC
t _{D(on)}	Turn-On DelayTime				24		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2.5 Ω , R_{GEN} =3 Ω			18		ns
$t_{D(off)}$	Turn-Off DelayTime				52		ns
t _f	Turn-Off Fall Time				22		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs			45		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μ	S		287		nC

A. The value of R_{aJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{aJA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

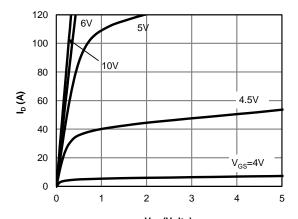
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

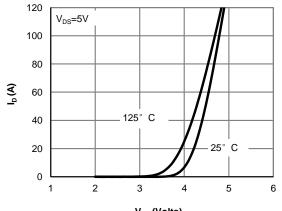
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C.



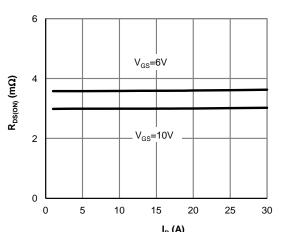
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



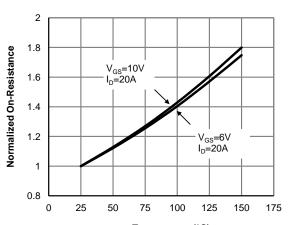
 V_{DS} (Volts) Figure 1: On-Region Characteristics (Note E)



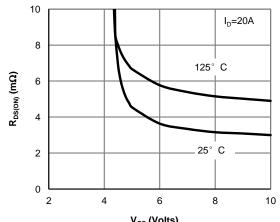
V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



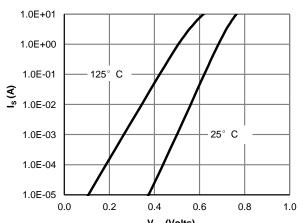
 ${
m I_D}\left({
m A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



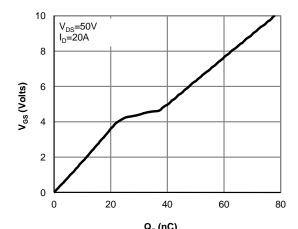
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



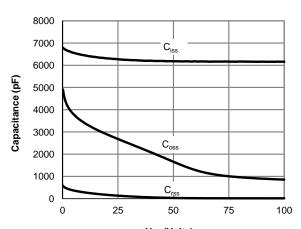
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



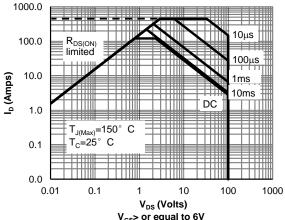
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



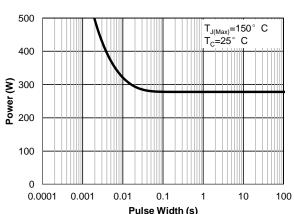
 $\rm Q_{\rm g}$ (nC) Figure 7: Gate-Charge Characteristics



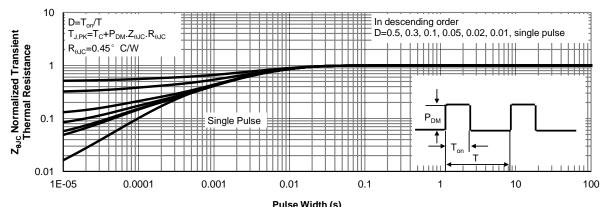
V_{DS} (Volts)
Figure 8: Capacitance Characteristics



V_{GS}> or equal to 6V Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

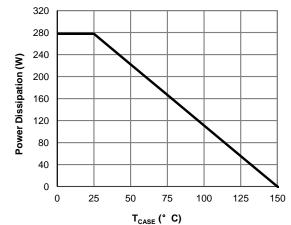
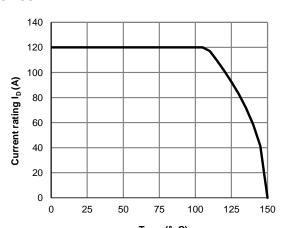
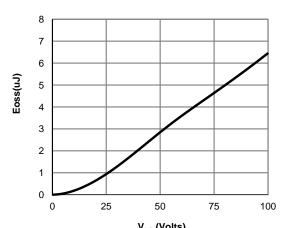


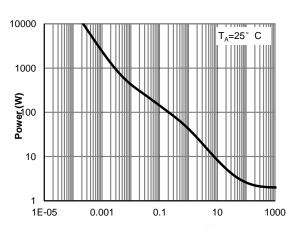
Figure 12: Power De-rating (Note F)



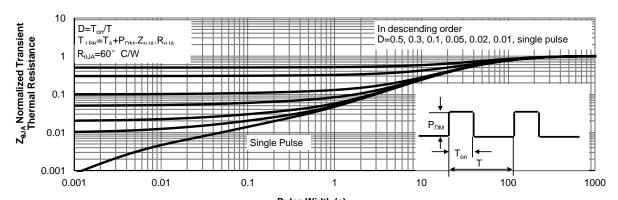
T_{CASE} (° C) Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Vdd

Figure A: Gate Charge Test Circuit & Waveforms

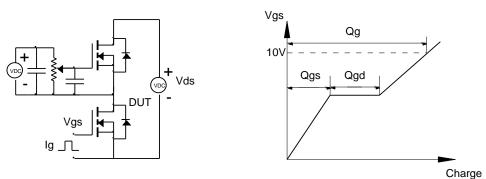


Figure B: Resistive Switching Test Circuit & Waveforms

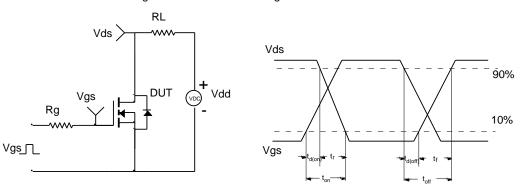


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

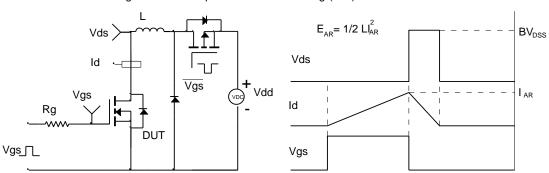


Figure D: Diode Recovery Test Circuit & Waveforms

